

# Search Notes



Application/Control No.

10/712,748

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2151

## SEARCHED

Class	Subclass	Date	Examiner
709	250	8/3/2006	JW

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
USPGPUB	test need of claims (see attached search history)	8/3/2006	JW

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
text search (see attached search history)	8/3/2006	JW
backward/forward citations of cited references (see attached search history)	8/3/2006	JW
inventor name search	8/3/2006	JW
IEEE xplore database search (see attached search history page)	8/3/2006	JW